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Mess- und Prüftechnik. Die Experten.

# PXI LCR Bundles

PC-based LCR Meters & SMUs with interactive measurement software

## Use PXI LCR Bundles for

- CV/IV testing with high channel density and no connection changes at the device under test (DUT)
- MEMS Structure Electrical Test
- Wafer Parametric Test
- Multilayer Ceramic Capacitor (MLCC) Validation & Test
- Combining measurements from different instruments in one system



## Popular Features

### 2-in-1

SMU and LCR meter combined in single instrument for an elegant bench solution

### Scalability

Combine with other types of instruments to build tightly integrated mixed-signal test systems

### Precision

Femtofarad-class capacitance measurements and femtoampere-class current measurements



# Do more in one box with NI PXI

The NI PXI LCR Bundles include a PXIe LCR Meter in a 5-slot PXI Express based measurement system that is controlled through your laptop's Thunderbolt™ USB-C port.

Achieve high accuracy, high productivity, and higher speeds with the standard for automated test and automated measurement: NI PXI (PCI eXtensions for Instrumentation).



Make DC and impedance measurements in a seamless fashion with NI's PXIe-4190 - the world's first LCR Meter and SMU in a single instrument. This instrument provides femto-farad (10-15) class capacitance measurements and femto-amp current measurements in a single-slot PXI form factor. The new PXIe-4190 also removes the need for an additional switch to multiplex between the LCR Meter and SMU, allowing for a simplified test experience with higher throughput and lower capital cost.

|                           | PXIe-LCR5100<br>P/N: 867113-01   | PXIe-LCR5101<br>P/N: 867126-01 |
|---------------------------|--|--------------------------------|
| <b>What is Included</b>   |  |                                |
| <b>Chassis</b>            | PXIe-1083  |                                |
| <b>Module</b>             | PXIe-4190 (40V)  | PXIe-4190 (10 V)               |
| <b>Accessories</b>        | Thunderbolt cable<br>Power cable, US<br>DSub-to-BNC cable for I/O connectivity |                                |
| <b>Key Specifications</b> |  |                                |
| <b>Bandwidth</b>          | 2 MHz  | 500 kHz                        |
| <b>Voltage Range</b>      | ± 40 V DC Bias   | ± 10 V DC Bias                 |
| <b>Max Current</b>        | 100 mA   | 100 mA                         |
| <b>Current Ranges</b>     | 100 mA, 10 mA, 1 mA<br>100 µA, 10 µA, 1µA, 10nA, 1nA                           | -100 mA - 100 mA               |



# Upgrade and do more with your system!

Don't be limited by vendor-defined configurations. Use the remaining 4 slots to build on top of your system and manage change. Add measurements, more channels, or new analysis routines without having to purchase a whole new instrument.

## Start with these best-selling modules



P/N: 783129-01

### Digital Multimeter

#### PXIe-4080

- 6 ½ digit,  $\pm 300$  V,  $\pm 1$  A
- 2- or 4-wire resistance measurements up to 5 G $\Omega$
- Isolated Digitizer mode - Up to 1.8 MS/s
- Frequency/period measurements
- Diode tests



P/N: 783590-02

### Oscilloscope

#### PXIe-5105

- 8 simultaneously-sampled channels
- 12-bit vertical resolution
- 60 MHz Bandwidth
- 60 MS/s sample rate



P/N: 781056-01

### Multifunction IO

#### PXIe-6363

- 32 Analog Input (16-bit, 2 MS/s)
- 4 Analog Output
- 48 DIO channels
- 4 32-bit counter/timers



P/N: 785114-01

### Waveform Generator

#### PXIe-5413

- 20 MHz Bandwidth
- Up to two 16-bit channels
- 800 MS/s
- $\pm 12$  V output range



P/N: 779647-11

### Power Supply

#### PXIe-4110

- Two isolated channels
- Single non-isolated channel
- Up to 20 V, 1 A per channel
- Up to 46 W output power
- Hardware timing and triggering
- Output disconnect relays
- Four-wire remote sense



P/N: 780587-27

### Multiplexer Switch

#### PXIe-2527

- 32 channel, 2-wire, 300 V, 2 A
- Electromechanical relay
- Supports 64x1 1-wire, 32x 2 2-wire, 16x1 4-wire configurations
- Onboard relay counting

Explore over 600 different PXI modules ranging from DC to mmWave.  
Contact your NI product expert to get help solving your test challenges.



# Select your software

## Interactive Measurement with InstrumentStudio

- **Control** all your instruments in a single, intuitive no-code application software.
- **Capture** screenshots, **export** data, and **share** projects with colleagues and between systems.
- **Monitor and debug** automated test systems

[Free! – Download Now](#)

## Graphical Programming in LabVIEW

- **Acquire, process, and analyze data** from NI hardware or any 3<sup>rd</sup> party instrument
- **Create interactive UIs** for test monitoring and control.
- **Save data** to .csv, .tdms, or any custom-defined binary file.

## Use Your Programming Language of Choice

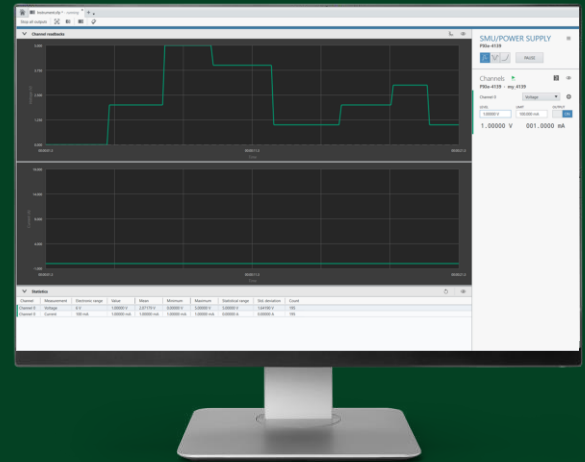
- **Drivers** for Python, C, C++, C#, .NET, and MATLAB®\*

## A Bundle of Software for Test

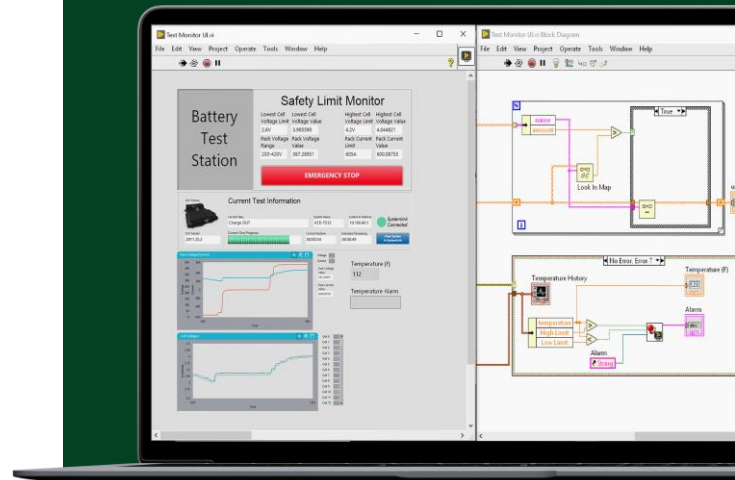
- **Develop** test systems faster with graphical programming in LabVIEW
- **Create** automated test sequences with TestStand
- **Build** web applications for test with G Web Development Software
- **Analyze** your data interactively with DIAdem
- **Perform** data acquisition and logging with FlexLogger

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With InstrumentStudio, view data from all your instruments unified on high-resolution monitors rather than small, integrated displays.



"The move to a COTS approach using PXI and LabVIEW was critical to this production-test success at Philips. The combination of best-in-class modular hardware along with industry-standard software was pivotal to the millions of dollars and hundreds of hours saved in production test engineering"

-Neil Evans  
Senior Manager, Philips

